Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/680,549	JAIN ET AL.
Examiner	Art Unit

2617

Olumide T. Ajibade-Akonai

SEARCHED				
Class	Subclass	Date	Examiner	
455	446	8/6/2007	OA	
455	445	8/6/2007	OA	
370	229	8/5/2007	OA	
370	238	8/5/2007	OA	
709	All	8/6/2007	OA 、	
NPL IEEE		8/7/2007	OA	
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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